

Notice of References Cited	Application/Control No. 09/812,031	Applicant(s)/Patent Under Reexamination TAWA ET AL.	
	Examiner Adam R. Giesy	Art Unit 2651	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,778,486 B1	08-2004	Arikawa et al.	369/112.29
	B	US-2004/0022141 A1	02-2004	Nakamura et al.	369/44.12
	C	US-2002/0039343 A1	04-2002	Shindo, Hiroyuki	369/112.29
	D	US-5,680,385	10-1997	Nagano, Tsuyoshi	369/112.03
	E	US-2002/0015363 A1	02-2002	Nemoto, Kazuhiko	369/44.12
	F	US-6,314,063 B1	11-2001	Nemoto, Kazuhiko	369/44.12
	G	US-2003/0231573 A1	12-2003	Matsumoto et al.	369/112.29
	H	US-6,496,469 B1	12-2002	Uchizaki, Ichiro	369/122
	I	US-5,181,193 A	01-1993	Kume et al.	369/44.23
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.